Power MOSFET Dual P-Channel ChipFET™

2.1 Amps, 20 Volts

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET Surface Mount Package Saves Board Space

Applications

Power Management in Portable and Battery–Powered Products; i.e.,
 Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V _{DS}	-20		V
Gate-Source Voltage	V _{GS}	±12		V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_{\Delta} = 85^{\circ}C$	I _D	±2.9 ±2.1	±2.1 www.BataS	A heet4U.com
Pulsed Drain Current	I _{DM}	±10		А
Continuous Source Current (Diode Conduction) (Note 1)	I _S	-1.8	-0.9	А
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to +150		°C

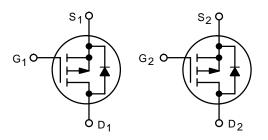
1. Surface Mounted on 1" x 1" FR4 Board.



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DUAL P-CHANNEL 2.1 AMPS, 20 VOLTS $R_{DS(on)} = 155 \text{ m}\Omega$



P-Channel MOSFET

P-Channel MOSFET



ChipFET CASE 1206A STYLE 2

PIN CONNECTIONS MARKING DIAGRAM D1 8 1 S1 1 O 8 7 D2 6 3 S2 3 0 6 D2 5 4 G2 4 0 5

ORDERING INFORMATION

A7 = Specific Device Code

Device	Package	Shipping		
NTHD5903T1	ChipFET	3000/Tape & Reel		

THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
$\label{eq:maximum Junction-to-Ambient (Note 2)} \begin{split} &t \leq 5 \text{ sec} \\ &\text{Steady State} \end{split}$	R _{thJA}	50 90	60 110	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R _{thJF}	30	40	°C/W

$\textbf{ELECTRICAL CHARACTERISTICS} \ (T_J = 25^{\circ}\text{C unless otherwise noted})$

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static	•			•	•	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.6	_	-	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	_	_	±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-1.0	μΑ
		$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	_	-	-5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \le -5.0 \text{ V}, V_{GS} = -4.5 \text{ V}$	-10	_	_	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	$V_{GS} = -4.5 \text{ V}, I_D = -2.1 \text{ A}$	-	0.130	0.155	Ω
		$V_{GS} = -3.6 \text{ V}, I_D = -2.0 \text{ A}$	-	0.150	0.180	
		$V_{GS} = -2.5 \text{ V}, I_D = -1.7 \text{ A}$	-	0.215	0.260	
Forward Transconductance (Note 3)	9 _{fs}	$V_{DS} = -10 \text{ V}, I_D = -2.1 \text{ A}$	-	5.0	_	S
Diode Forward Voltage (Note 3)	V _{SD}	$I_S = -0.9 \text{ A}, V_{GS} = 0 \text{ V}$	-	-0.8	-1.2	V
ynamic (Note 4)	•		•	•	•	
Total Gate Charge	Qg		-	3.0	6.0	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V},$ $I_{D} = -2.1 \text{ A}$	-	0.9	_	
Gate-Drain Charge	Q _{gd}		-	0.6	-	
Turn-On Delay Time	t _{d(on)}		-	13	20	ns
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_L = 10 \Omega$	_	35	55	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -1.0 \text{ A}, V_{GEN} = -4.5 \text{ V},$ $R_G = 6 \Omega$	_	25	40	
Fall Time	t _f		_	25	40	
Source-Drain Reverse Recovery Time	t	$I_{r} = -0.9 \text{ A. di/dt} = 100 \text{ A/us}$	_	40	80	1

Surface Mounted on 1" x 1" FR4 Board.
 Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

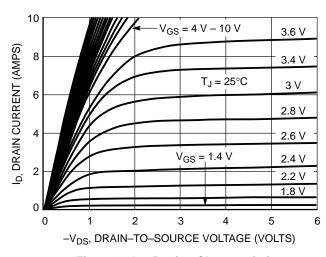


Figure 1. On-Region Characteristics

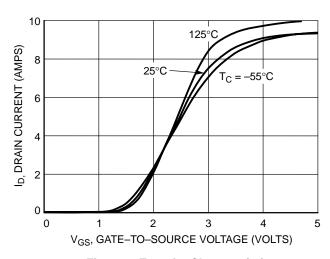


Figure 2. Transfer Characteristics

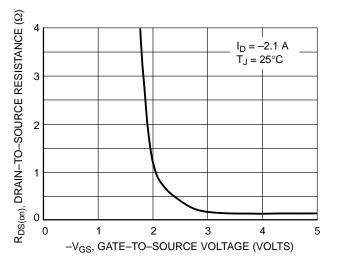


Figure 3. On–Resistance vs. Gate–to–Source Voltage

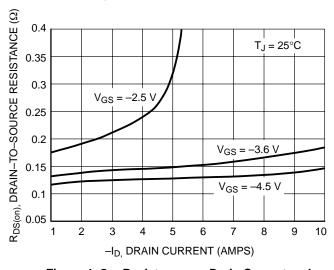


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

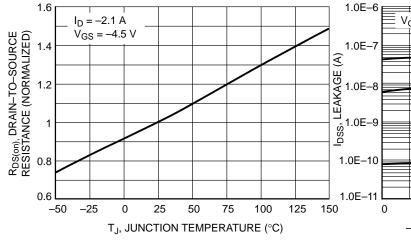


Figure 5. On–Resistance Variation with Temperature

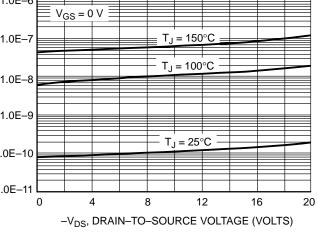
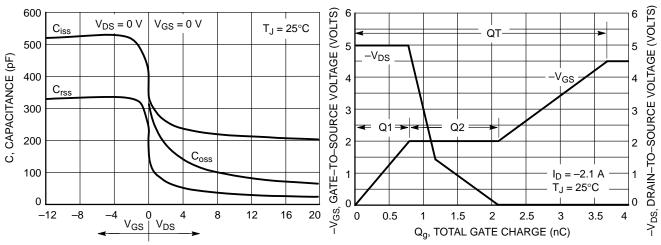


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL ELECTRICAL CHARACTERISTICS



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 7. Capacitance Variation

Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

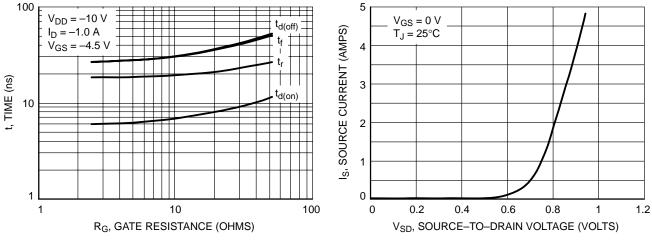


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

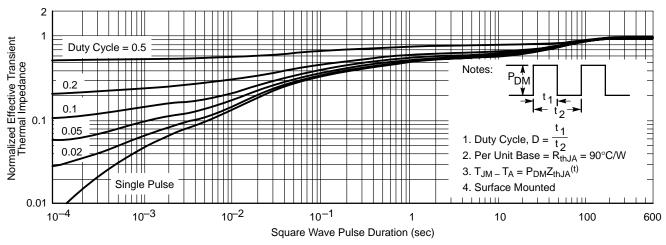


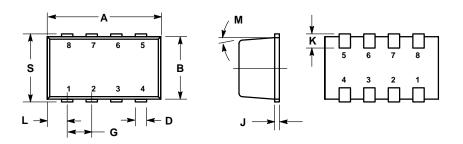
Figure 11. Normalized Thermal Transient Impedance, Junction-to-Ambient

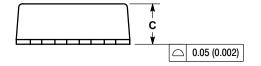
Notes

Notes

PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 ISSUE D





STYLE 2:
PIN 1. SOURCE 1
2. GATE 1
3. SOURCE 2
4. GATE 2
5. DRAIN 2
6. DRAIN 2
7. DRAIN 1
8. DRAIN 1

- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
 3. MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE.
 4. LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED 0.08 MM.
 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
 6. NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
 7. 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M	5° NOM		5 ° NOM		
S	1.80	2.00	0.072	0.080	

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